



Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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SIPMOS® Power-Transistor

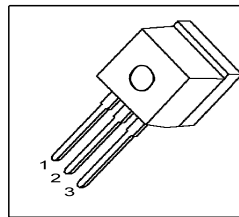
Feature

- N-Channel
- Enhancement mode
- 175°C operating temperature
- Avalanche rated
- dv/dt rated

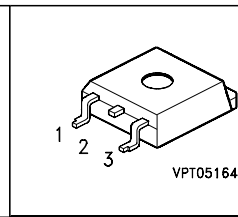
Product Summary

V_{DS}	100	V
$R_{DS(on)}$	180	mΩ
I_D	10.3	A

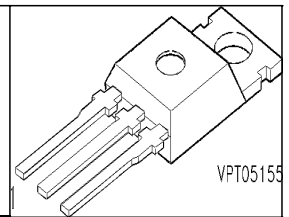
P-TO262-3-1



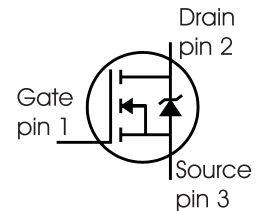
P-TO263-3-2



P-TO220-3-1



Type	Package	Ordering Code	Marking
SPP10N10	P-TO220-3-1	-	10N10
SPB10N10	P-TO263-3-2	-	10N10
SPI10N10	P-TO262-3-1	-	10N10



Maximum Ratings, at $T_j = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current	I_D	10.3	A
$T_C=25^\circ\text{C}$			
$T_C=100^\circ\text{C}$		-	
Pulsed drain current	$I_D \text{ puls}$	41.2	
$T_C=25^\circ\text{C}$			
Avalanche energy, single pulse	E_{AS}	60	mJ
$I_D=10.3 \text{ A}$, $V_{DD}=25\text{V}$, $R_{GS}=25\Omega$			
Reverse diode dv/dt	dv/dt	6	kV/ μs
$I_S=10.3\text{A}$, $V_{DS}=80\text{V}$, $di/dt=200\text{A}/\mu\text{s}$, $T_{jmax}=175^\circ\text{C}$			
Gate source voltage	V_{GS}	± 20	V
Power dissipation	P_{tot}	50	W
$T_C=25^\circ\text{C}$			
Operating and storage temperature	T_j, T_{stg}	-55... +175	$^\circ\text{C}$
IEC climatic category; DIN IEC 68-1		55/175/56	

Thermal Characteristics

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Characteristics					
Thermal resistance, junction - case	R_{thJC}	-	-	3	K/W
Thermal resistance, junction - ambient, leaded	R_{thJA}	-	-	100	
SMD version, device on PCB:	R_{thJA}				
@ min. footprint		-	-	75	
@ 6 cm ² cooling area ¹⁾		-	-	50	

Electrical Characteristics, at $T_j = 25\text{ }^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Static Characteristics					
Drain-source breakdown voltage $V_{GS}=0V, I_D=1mA$	$V_{(BR)DSS}$	100	-	-	V
Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D = 21\ \mu A$	$V_{GS(th)}$	2.1	3	4	
Zero gate voltage drain current $V_{DS}=100V, V_{GS}=0V, T_j=25^\circ C$ $V_{DS}=100V, V_{GS}=0V, T_j=125^\circ C$	I_{DSS}	-	0.01	1	μA
		-	1	100	
Gate-source leakage current $V_{GS}=20V, V_{DS}=0V$	I_{GSS}	-	1	100	nA
Drain-source on-state resistance $V_{GS}=10V, I_D=-A$	$R_{DS(on)}$	-	tbd	180	m Ω

¹Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical without blown air.

Electrical Characteristics, at $T_j = 25\text{ }^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic Characteristics

Transconductance	g_{fs}	$V_{DS} \geq 2 \cdot I_D \cdot R_{DS(on)max}$, $I_D = -A$	tbd	tbd	-	S
Input capacitance	C_{iss}	$V_{GS} = 0V$, $V_{DS} = 25V$, $f = 1MHz$	-	tbd	tbd	pF
Output capacitance	C_{oss}		-	tbd	tbd	
Reverse transfer capacitance	C_{rss}		-	tbd	tbd	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 50V$, $V_{GS} = 10V$, $I_D = 10.3A$, $R_G = 28\Omega$	-	tbd	tbd	ns
Rise time	t_r		-	tbd	tbd	
Turn-off delay time	$t_{d(off)}$		-	tbd	tbd	
Fall time	t_f		-	tbd	tbd	

Gate Charge Characteristics

Gate to source charge	Q_{gs}	$V_{DD} = 80V$, $I_D = 10.3A$	-	tbd	tbd	nC
Gate to drain charge	Q_{gd}		-	tbd	tbd	
Gate charge total	Q_g	$V_{DD} = 80V$, $I_D = 10.3A$, $V_{GS} = 0$ to $10V$	-	tbd	tbd	
Gate plateau voltage	$V_{(plateau)}$	$V_{DD} = 80V$, $I_D = 10.3A$	-	tbd	-	V

Reverse Diode

Inverse diode continuous forward current	I_S	$T_C = 25^\circ\text{C}$	-	-	10.3	A
Inverse diode direct current, pulsed	I_{SM}		-	-	41.2	
Inverse diode forward voltage	V_{SD}	$V_{GS} = 0V$, $I_F = 10.3A$	-	tbd	tbd	V
Reverse recovery time	t_{rr}	$V_R = 50V$, $I_F = I_S$, $di_F/dt = 100A/\mu s$	-	tbd	tbd	ns
Reverse recovery charge	Q_{rr}		-	tbd	tbd	nC

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